Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/936,426	KANNO ET AL.
Examiner	Art Unit
Hien Tran	1764

	OTABOUTD.				
SEARCHED					
Class	Subclass	Date	Examiner		
422	168-173, 177	2/3/2005	нт		
updated	search	7/19/2005	нт		
updated	search	1/31/2006	HT		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East Image class/subclass search / Inventors' names search / Text search	2/3/2005	нт
updated search	7/19/2005	нт
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